Onsemi

3.3 V Dual LVTTL/LVCMOS to Differential LVPECL Translator

MC100EPT22

Description

The MC100EPT22 is a dual LVTTL/LVCMOS to differential LVPECL translator. Because LVPECL (Positive ECL) levels are used only +3.3 V and ground are required. The small outline 8-lead package and the single gate of the EPT22 makes it ideal for those applications where space, performance, and low power are at a premium. Because the mature MOSAIC 5 process is used, low cost and high speed can be added to the list of features.

Features

- 420 ps Typical Propagation Delay
- Maximum Frequency = > 1.1 GHz Typical
- Operating Range: $V_{CC} = 3.0 \text{ V}$ to 3.6 V with GND = 0 V
- PNP LVTTL Inputs for Minimal Loading
- Q Output Will Default HIGH with Inputs Open
- The 100 Series Contains Temperature Compensation.
- These Devices are Pb-Free, Halogen Free and are RoHS Compliant

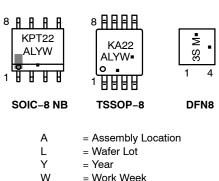




SOIC-8 NB TSSOP-8 DFN8 D SUFFIX DT SUFFIX CASE 751-07 CASE 948R-02 CASE 506AA

MARKING DIAGRAMS*

MN SUFFIX



| W | = Work Week |
|---|-------------|
| М | = Date Code |

| = Pb-Free | Package |
|-----------|---------|
|-----------|---------|

(Note: Microdot may be in either location)

*For additional marking information, refer to Application Note AND8002/D.

ORDERING INFORMATION

| Device | Package | Shipping† |
|-----------------|------------------------|------------------|
| MC100EPT22DG | SOIC-8 NB (Pb-Free) | 98 Units/Tube |
| MC100EPT22DR2G | SOIC-8 NB (Pb-Free) | 2500 Tape & Reel |
| MC100EPT22DTG | TSSOP-8 (Pb-Free) | 100 Tape & Reel |
| MC100EPT22DTR2G | TSSOP-8 (Pb-Free) | 2500 Tape & Reel |
| MC100EPT22MNR4G | DFN8 (Pb–Free) | 1000 Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

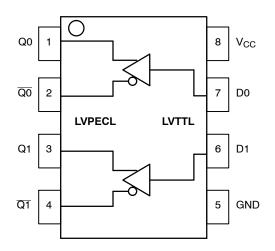




Table 1. PIN DESCRIPTION

| PIN | FUNCTION |
|-------------------------------|--|
| Q0, Q1, <u>Q0</u> , <u>Q1</u> | LVPECL Differential Outputs |
| D0, D1 | LVTTL Inputs |
| V _{CC} | Positive Supply |
| GND | Ground |
| EP | (DFN8 only) Thermal exposed pad must be connected to a sufficient ther- mal conduit. Electrically connect to the most negative supply (GND) or leave unconnected, floating open. |

| Table 2 | ATTRIBUTES |
|----------|------------|
| Taple 2. | AIIRIDUIES |

| Value |
|-------------------------------|
| N/A |
| N/A |
| > 4 kV > 200 V > 2 kV |
| Pb-Free Pkg |
| Level 1 Level 3 Level 1 |
| UL 94 V-0 @ 0.125 in |
| 164 Devices |
| |

1. For additional information, see Application Note AND8003/D.

Table 3. MAXIMUM RATINGS

| Symbol | Parameter | Condition 1 | Condition 2 | Rating | Unit |
|------------------|--|---------------------|------------------------|-------------|------|
| V _{CC} | Power Supply | GND = 0 V | | 6 | V |
| VI | Input Voltage | GND = 0 V | $V_{I} \le V_{CC}$ | 6 to 0 | V |
| I _{out} | Output Current | Continuous Surge | | 50 100 | mA |
| T _A | Operating Temperature Range | | | -40 to +85 | °C |
| T _{stg} | Storage Temperature Range | | | -65 to +150 | °C |
| θ_{JA} | Thermal Resistance (Junction-to-Ambient) | 0 lfpm 500 lfpm | SOIC-8 NB SOIC-8 NB | 190 130 | °C/W |
| θ_{JC} | Thermal Resistance (Junction-to-Case) | Standard Board | SOIC-8 NB | 41 to 44 | °C/W |
| θ_{JA} | Thermal Resistance (Junction-to-Ambient) | 0 lfpm 500 lfpm | TSSOP-8 TSSOP-8 | 185 140 | °C/W |
| θ_{JC} | Thermal Resistance (Junction-to-Case) | Standard Board | TSSOP-8 | 41 to 44 | °C/W |
| θ_{JA} | Thermal Resistance (Junction-to-Ambient) | 0 lfpm 500 lfpm | DFN8 DFN8 | 129 84 | °C/W |
| T _{sol} | Wave Solder (Pb-Free) | | | 265 | °C |
| θ_{JC} | Thermal Resistance (Junction-to-Case) | (Note 2) | DFN8 | 35 to 40 | °C/W |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

2. JEDEC standard multilayer board - 2S2P (2 signal, 2 power)

| Symbol | Characteristic | Condition | Min | Тур | Max | Unit |
|------------------|------------------------|-----------------------------------|-----|-----|------|------|
| I _{IH} | Input HIGH Current | V _{IN} = 2.7 V | | | 20 | μΑ |
| I _{IHH} | Input HIGH Current MAX | V _{IN} = V _{CC} | | | 100 | μΑ |
| IIL | Input LOW Current | V _{IN} = 0.5 V | | | -0.6 | mA |
| V _{IK} | Input Clamp Voltage | I _{IN} = -18 mA | | | -1.0 | V |
| V _{IH} | Input HIGH Voltage | | 2.0 | | | V |
| V _{IL} | Input LOW Voltage | | | | 0.8 | V |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

| | | -40°C | | | 25°C | | | 85°C | | | |
|-----------------|------------------------------|-------|------|------|------|------|------|------|------|------|------|
| Symbol | Characteristic | Min | Тур | Max | Min | Тур | Max | Min | Тур | Max | Unit |
| I _{CC} | Power Supply Current | 32 | 43 | 55 | 35 | 45 | 60 | 37 | 46 | 62 | mA |
| V _{OH} | Output HIGH Voltage (Note 4) | 2155 | 2280 | 2405 | 2155 | 2280 | 2405 | 2155 | 2280 | 2405 | mV |
| V _{OL} | Output LOW Voltage (Note 4) | 1355 | 1480 | 1605 | 1355 | 1480 | 1605 | 1355 | 1480 | 1605 | mV |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

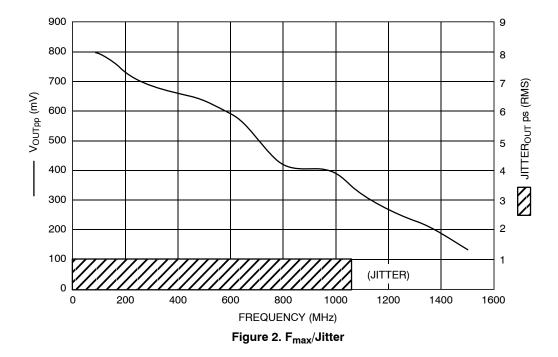
3. Output parameters vary 1:1 with V_{CC}. 4. All loading with 50 Ω to V_{CC} – 2.0 V.

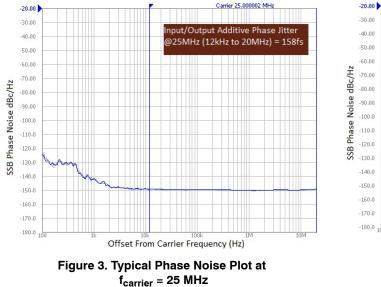
| | | −40°C | | | 25°C | | | 85°C | | | |
|--|---|--------------|-----------|------------|------|--------------|------------|------|-----------|------------|------|
| Symbol | Characteristic | Min | Тур | Max | Min | Тур | Max | Min | Тур | Max | Unit |
| f _{max} | Maximum Frequency (Figure 2) | 0.8 | 1.1 | | 0.8 | 1.1 | | 0.8 | 1.1 | | GHz |
| t _{PLH} , t _{PHL} | Propagation Delay to Output Differential | 250 | 400 | 650 | 250 | 420 | 675 | 300 | 500 | 700 | ps |
| t _{skew} | Within-Device Skew (Note 6) Device-to-Device Skew (Note 7) | | 50 200 | 100 400 | | 50 200 | 100 425 | | 50 200 | 100 400 | ps |
| t _{JITTER} | Random Clock Jitter (Figure 2) | | 0.2 | < 1 | | 0.2 | < 1 | | 0.2 | < 1 | ps |
| tJIT(Φ) | Additive Phase RMS Jitter Integration Range 12 kHz to 20 MHz 25 MHz 156.25 MHz | | | | | 0.05 0.16 | | | | | ps |
| t _r t _f | Output Rise/Fall Times Q, Q (20%–80%) | 50 | 110 | 200 | 60 | 120 | 220 | 70 | 140 | 250 | ps |

Table 6. AC CHARACTERISTICS (V_{CC} = 3.0 V to 3.6 V, GND = 0.0 V (Note 5))

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

5. Measured using a 2.4 V source, 50% duty cycle clock source. All loading with 50 Ω to V_{CC} – 2.0 V. 6. Skew is measured between outputs under identical transitions and conditions on any one device. 7. Device-to-Device Skew for identical transitions at identical V_{CC} levels.





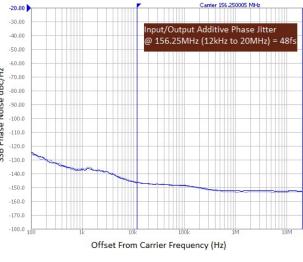


Figure 4. Typical Phase Noise Plot at f_{carrier} = 156.25 MHz

The above phase noise plots captured using Agilent E5052A show additive phase noise of the MC100EPT22 device at frequencies 25 MHz and 156.25 MHz respectively at an operating voltage of 3.3 V in room temperature. The RMS Phase Jitter contributed by the device (integrated

between 12 kHz and 20 MHz; as shown in the shaded region of the plot) at each of the frequencies is 158 fs and 48 fs respectively. The input source used for the phase noise measurements is Agilent E8663B.

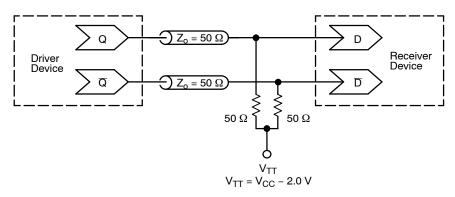


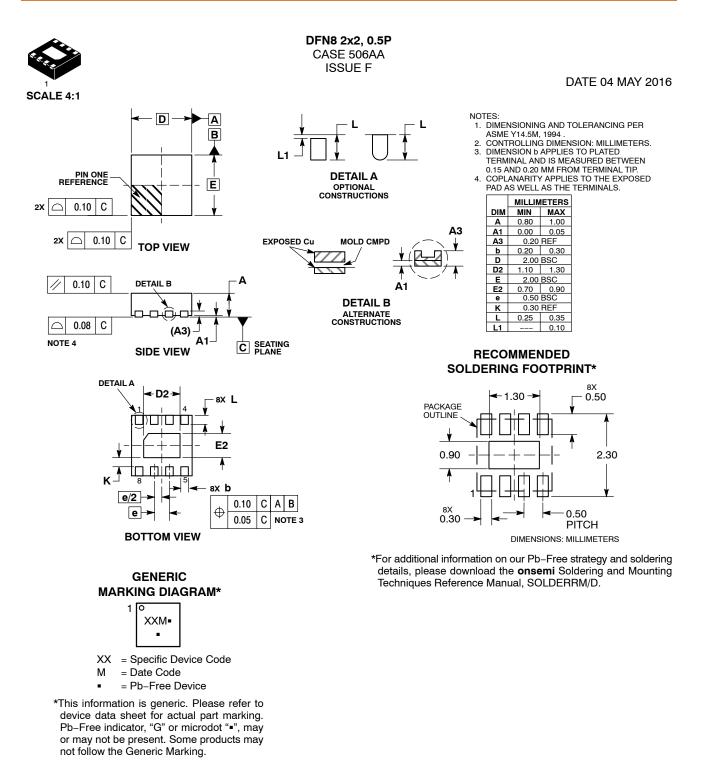
Figure 5. Typical Termination for Output Driver and Device Evaluation (See Application Note <u>AND8020/D</u> – Termination of ECL Logic Devices)

Resource Reference of Application Notes

| AN1405/D | - | ECL Clock Distribution Techniques | | |
|-----------|---|---|--|--|
| AN1406/D | - | Designing with PECL (ECL at +5.0 V) | | |
| AN1503/D | - | ECLinPS [™] I/O SPiCE Modeling Kit | | |
| AN1504/D | - | Metastability and the ECLinPS Family | | |
| AN1568/D | - | Interfacing Between LVDS and ECL | | |
| AN1672/D | - | The ECL Translator Guide | | |
| AND8001/D | - | Odd Number Counters Design | | |
| AND8002/D | - | Marking and Date Codes | | |
| AND8020/D | - | Termination of ECL Logic Devices | | |
| AND8066/D | - | Interfacing with ECLinPS | | |
| AND8090/D | - | AC Characteristics of ECL Devices | | |
| | | | | |

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*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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SOIC-8 NB CASE 751-07 **ISSUE AK**

STYLE 1: PIN 1. EMITTER COLLECTOR 2. 3. COLLECTOR 4. EMITTER 5. EMITTER BASE 6. 7 BASE EMITTER 8. STYLE 5: PIN 1. DRAIN 2. DRAIN 3. DRAIN DRAIN 4. GATE 5. 6. GATE SOURCE 7. 8. SOURCE STYLE 9: PIN 1. EMITTER, COMMON COLLECTOR, DIE #1 COLLECTOR, DIE #2 2. З. EMITTER, COMMON 4. 5. EMITTER, COMMON 6 BASE. DIE #2 BASE, DIE #1 7. 8. EMITTER, COMMON STYLE 13: PIN 1. N.C. 2. SOURCE 3 GATE 4. 5. DRAIN 6. DRAIN DRAIN 7. DRAIN 8. STYLE 17: PIN 1. VCC 2. V2OUT V10UT З. TXE 4. 5. RXE 6. VFF 7. GND 8. ACC STYLE 21: PIN 1. CATHODE 1 2. CATHODE 2 3 CATHODE 3 CATHODE 4 4. 5. CATHODE 5 6. COMMON ANODE COMMON ANODE 7. 8. CATHODE 6 STYLE 25: PIN 1. VIN 2 N/C REXT З. 4. GND 5. IOUT IOUT 6. IOUT 7. 8. IOUT STYLE 29: BASE, DIE #1 PIN 1. 2 EMITTER, #1 BASE, #2 З. EMITTER, #2 4. 5 COLLECTOR, #2 COLLECTOR, #2 6.

STYLE 2: PIN 1. COLLECTOR, DIE, #1 2. COLLECTOR, #1 COLLECTOR, #2 3. 4 COLLECTOR, #2 BASE, #2 5. EMITTER, #2 6. 7 BASE #1 EMITTER, #1 8. STYLE 6: PIN 1. SOURCE 2. DRAIN 3. DRAIN SOURCE 4. SOURCE 5. 6. GATE GATE 7. 8. SOURCE STYLE 10: GROUND PIN 1. BIAS 1 OUTPUT 2. З. GROUND 4. 5. GROUND 6 BIAS 2 INPUT 7. 8. GROUND STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3 P-SOURCE P-GATE 4. P-DRAIN 5 6. P-DRAIN N-DRAIN 7. N-DRAIN 8. STYLE 18: PIN 1. ANODE ANODE 2. SOURCE 3. GATE 4. 5. DRAIN 6 DRAIN CATHODE 7. CATHODE 8. STYLE 22 PIN 1. I/O LINE 1 2. COMMON CATHODE/VCC 3 COMMON CATHODE/VCC 4. I/O LINE 3 COMMON ANODE/GND 5. 6. I/O LINE 4 7. I/O LINE 5 8. COMMON ANODE/GND STYLE 26: PIN 1. GND 2 dv/dt З. ENABLE 4. ILIMIT 5. SOURCE SOURCE 6. SOURCE 7. 8. VCC STYLE 30: DRAIN 1 PIN 1. DRAIN 1 2 GATE 2 З. SOURCE 2 4 SOURCE 1/DRAIN 2 SOURCE 1/DRAIN 2 5.

6.

7.

8 GATE 1

SOURCE 1/DRAIN 2

STYLE 3: PIN 1. DRAIN, DIE #1 DRAIN, #1 2. DRAIN, #2 З. DRAIN, #2 4. GATE, #2 5. SOURCE, #2 6. 7 GATE #1 8. SOURCE, #1 STYLE 7: PIN 1. INPUT 2. EXTERNAL BYPASS THIRD STAGE SOURCE GROUND З. 4. 5. DRAIN 6. GATE 3 SECOND STAGE Vd 7. FIRST STAGE Vd 8. STYLE 11: PIN 1. SOURCE 1 GATE 1 SOURCE 2 2. З. GATE 2 4. 5. DRAIN 2 6. DRAIN 2 DRAIN 1 7. 8. DRAIN 1 STYLE 15: PIN 1. ANODE 1 2. ANODE 1 ANODE 1 3 ANODE 1 4. 5. CATHODE, COMMON CATHODE, COMMON CATHODE, COMMON 6. 7. CATHODE, COMMON 8. STYLE 19: PIN 1. SOURCE 1 GATE 1 SOURCE 2 2. 3. GATE 2 4. 5. DRAIN 2 6. MIRROR 2 7. DRAIN 1 MIRROR 1 8. STYLE 23: PIN 1. LINE 1 IN COMMON ANODE/GND COMMON ANODE/GND 2. 3 LINE 2 IN 4. LINE 2 OUT 5. COMMON ANODE/GND COMMON ANODE/GND 6. 7. 8. LINE 1 OUT STYLE 27: PIN 1. ILIMIT OVI O 2 UVLO З. 4. INPUT+ 5. 6. SOURCE SOURCE SOURCE 7. 8 DRAIN

DATE 16 FEB 2011

STYLE 4: PIN 1. 2. ANODE ANODE ANODE З. 4. ANODE ANODE 5. 6. ANODE 7 ANODE COMMON CATHODE 8. STYLE 8: PIN 1. COLLECTOR, DIE #1 2. BASE, #1 З. BASE #2 COLLECTOR, #2 4. COLLECTOR, #2 5. 6. EMITTER, #2 EMITTER, #1 7. 8. COLLECTOR, #1 STYLE 12: PIN 1. SOURCE SOURCE 2. 3. GATE 4. 5. DRAIN 6 DRAIN DRAIN 7. 8. DRAIN STYLE 16 EMITTER, DIE #1 PIN 1. 2. BASE, DIE #1 EMITTER, DIE #2 3 BASE, DIE #2 4. 5. COLLECTOR, DIE #2 6. COLLECTOR, DIE #2 COLLECTOR, DIE #1 7. COLLECTOR, DIE #1 8. STYLE 20: PIN 1. SOURCE (N) GATE (N) SOURCE (P) 2. 3. 4. GATE (P) 5. DRAIN 6. DRAIN DRAIN 7. 8. DRAIN STYLE 24: PIN 1. BASE EMITTER 2. 3 COLLECTOR/ANODE COLLECTOR/ANODE 4. 5. CATHODE 6. CATHODE COLLECTOR/ANODE 7. 8. COLLECTOR/ANODE STYLE 28: PIN 1. SW_TO_GND 2. DASIC OFF DASIC_SW_DET З. 4. GND 5. 6. V MON VBULK 7. VBULK 8 VIN

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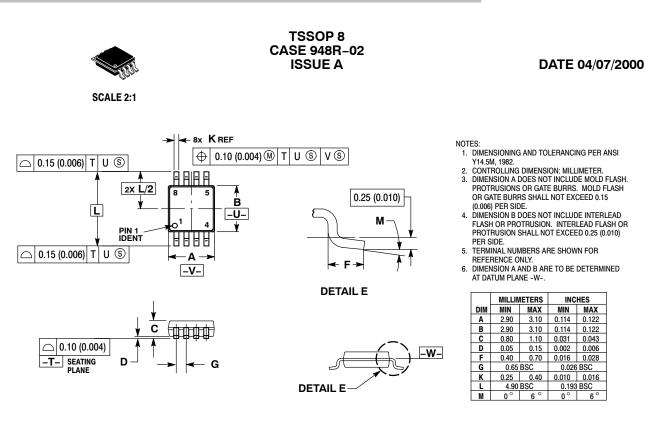
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